A Kernelized Stein Discrepancy for Goodness-of-fit Tests

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• Goodness-of-fit (GOF) tests: Given a distribution p and observation $\{x_i\}$ (drawn from unknown q), test

$$H_0: \{\mathbf{x}_i\}$$
 is drawn from p (or $p = q$)

• Motivation: checking model assumptions, model evaluation, etc.

 We are interested in complex, high dimensional distributions p(x), often with intractable normalization constants.

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Challenges:

- Classical GOF tests, such as chi-square, Kolmogorov-Smirnov, only works for simple, low dimensional distributions.
- We can simulate {y_i} ~ p and perform two-sample tests (e.g., by maximum mean discrepancy (MMD)): would not work when it is intractable to draw sample from p (MCMC may be needed).

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Stein's Method [Stein, 1972]

• A general theoretical tool for bounding differences between distributions

- Mostly used for theoretical proof: central limit theorem, concentration inequalities, etc.
- Key idea: Characterizing a distribution p with a Stein operator \mathcal{A}_p , such that

$$p = q \quad \iff \quad \mathbb{E}_{x \sim q}[\mathcal{A}_p f(x)] = 0.$$

• For continuous distributions with smooth density p(x),

 $\mathcal{A}_p f(x) \stackrel{\text{def}}{=} \nabla_x \log p(x) \cdot f(x)^\top + \nabla_x f(x).$

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• Score function $s_p(x) = \nabla_x \log p(x) = \frac{\nabla_x p(x)}{p(x)}$, independent of normalization constant Z!

Stein's Method

p = q, Stein's Identity : $\mathbb{E}_{x \sim p} [\nabla_x \log p(x) \cdot f(x)^\top + \nabla_x f(x)] = 0$:

Why?

• Use integration by parts, assuming zero boundary conditions.

$$\int p'(x)f(x) + p(x)f'(x)dx = p(x)f(x)\big|_{-\infty}^{+\infty} = 0.$$

Stein's Method

 $p \neq q \quad \Rightarrow \quad \exists \text{ some } f, \quad \mathbb{E}_{x \sim q}[\mathcal{A}_p f(x)] \neq 0:$

Why?

• We can show (denote $\boldsymbol{s}_p(x) = \nabla_x \log p(x)$):

$$\mathbb{E}_{\mathbf{x}\sim \boldsymbol{q}}[\mathcal{A}_{\boldsymbol{\rho}}f(\mathbf{x})] = \mathbb{E}_{\mathbf{x}\sim \boldsymbol{q}}[\mathcal{A}_{\boldsymbol{\rho}}f(\mathbf{x})] - \mathbb{E}_{\mathbf{x}\sim \boldsymbol{q}}[\mathcal{A}_{\boldsymbol{q}}f(\mathbf{x})]$$
$$= \mathbb{E}_{\mathbf{x}\sim \boldsymbol{q}}[(\boldsymbol{s}_{\boldsymbol{\rho}}(\mathbf{x}) - \boldsymbol{s}_{\boldsymbol{q}}(\mathbf{x}))f(\mathbf{x})^{\top}]$$

- Stein operator: essentially the inner product with the difference of score functions $(\boldsymbol{s}_p(x) \boldsymbol{s}_q(x))$.
- Unless s_p(x) ≡ s_q(x), we can always find an f(x) to get non-zero.

Stein's Identity

$$\mathbb{E}_{x \sim p}[\nabla_x \log p(x) \cdot f(x)^\top + \nabla_x f(x)] = 0.$$

Stein's identity: an infinite number of identities, indexed by function f

has found lots of applications in machine learning:

- Learning probabilistic models from data
 - Score matching [Hyvärinen, 2005, Lyu, 2009, Sriperumbudur et al., 2013]
 - Spectrum methods [Sedghi and Anandkumar, 2014]
- Variance reduction [Oates et al., 2014, 2016, 2017]
- Feature learning [Janzamin et al., 2014]
- Optimization [Erdogdu, 2015]

and many more ...

Stein Discrepancy

$$p \neq q \implies \exists f, \text{ such that } \mathbb{E}_{x \sim q}[\mathcal{A}_p f(x)] \neq 0$$

• Define (Squared) Stein discrepancy between p and q:

$$\sqrt{\mathbb{S}(\boldsymbol{q}, \boldsymbol{p})} = \max_{f \in \mathcal{F}} \mathbb{E}_{x \sim \boldsymbol{q}}[\operatorname{trace}(\mathcal{A}_{\boldsymbol{p}}f(x))]$$

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Kernelized Stein discrepancy (KSD)

- Let k(x, x') be a positive definite kernel, and \mathcal{H} its related reproducing kernel Hilbert space (RKHS). $\mathcal{H}^d = \mathcal{H} \times \cdots \times \mathcal{H}$.
- Kernelized Stein discrepancy: take \mathcal{F} to be the unit ball of RKHS.

$$\sqrt{\mathbb{S}(q, p)} = \max_{f \in \mathcal{F}} \mathbb{E}_{x \sim q}[\operatorname{trace}(\mathcal{A}_p f(x))], \quad f = \{f \in \mathcal{H}^d : ||f||_{\mathcal{H}^d} \leq 1\}$$

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then it has a closed form solution

$$\mathbb{S}(q, p) = \mathbb{E}_{x, x' \sim q}[\kappa_p(x, x')]$$

where
$$\kappa_p(x, x') = \operatorname{trace}(\mathcal{A}_p^x \mathcal{A}_p^{x'} k(x, x'))$$

= $s_p(x)^\top k(x, x') s_p(x') + s_p(x)^\top \nabla_{x'} k(x, x') + \nabla_x k(x, x')^\top s_p(x') + \Delta k(x, x')$

where \mathcal{A}_{p}^{\times} is Stein operator w.r.t. x.

Liu et al. (Dartmouth)

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$$\mathbb{S}(q, p) = \mathbb{E}_{x, x' \sim q}[\kappa_p(x, x')] \approx \frac{1}{\mathsf{n}(\mathsf{n} - 1)} \sum_{i \neq j} \kappa_p(\mathsf{x}_i, \mathsf{x}_j)$$
empirical estimation

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Empirical Estimation and Goodness-of-fit Tests

• Given $\{x_i\} \sim q(x)$, we can get an unbiased estimator of S(q, p) by U-statistic:

$$\hat{S}(\boldsymbol{q}, \boldsymbol{p}) = \frac{1}{n(n-1)} \sum_{i \neq j} \kappa_{\boldsymbol{p}}(\boldsymbol{x}_i, \boldsymbol{x}_j).$$

• Asymptotic distribution is well understood:

• If $p \neq q$, $\hat{S}(q, p) = S(q, p) + O_p(1/\sqrt{n})$ (asymptotic normal) • If p = q, $\hat{S}(q, p) = O_p(1/n)$. (infinite sum of χ^2 distributions)

• Goodness-of-fit test:

- Reject p = q if $\hat{S}(q, p) > \gamma$.
- Threshold γ decided using a generalized bootstrap procedure by Arcones and Gine [1992], Huskova and Janssen [1993].

Kernelized Stein Discrepancy (KSD)

• Is KSD a valid discrepancy: $p = q \iff \mathbb{S}(q, p) = 0$?

• We can show

$$S(q, p) = \mathbb{E}_{x, x' \sim q}[(\boldsymbol{s}_{p}(x) - \boldsymbol{s}_{q}(x))^{\top} k(x, x')(\boldsymbol{s}_{p}(x') - \boldsymbol{s}_{q}(x'))]$$

(Recall that $\mathbb{E}_{q}[\mathcal{A}_{p}f(x)] = \mathbb{E}_{q}[(\boldsymbol{s}_{p}(x) - \boldsymbol{s}_{q}(x))f(x)^{\top}]$)

• We just need k(x, x') to be integrally strictly positive definite:

$$\int g(x)k(x,x')g(x')dx > 0 \quad \forall g \in L_2 \setminus \{0\}$$

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(Recall that $\mathbb{E}_{\boldsymbol{q}}[\mathcal{A}_{\boldsymbol{p}}f(\boldsymbol{x})] = \mathbb{E}_{\boldsymbol{q}}[(\boldsymbol{s}_{\boldsymbol{p}}(\boldsymbol{x}) - \boldsymbol{s}_{\boldsymbol{q}}(\boldsymbol{x}))f(\boldsymbol{x})^{\top}])$

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Empirical Results

• 1D Gaussian mixture model (GMM)

- Simulate samples either from the true, or the perturbed model with equal probabilities
- Use GOF tests to tell if the sample is drawn from the true model (significance $\alpha = 0.05$).





Gaussian-Bernoulli Restricted Boltzmann Machine

- Gaussian visible nodes + binary hidden nodes.
- Computationally intractable to draw exact sample, or calculate the normalization constant (and likelihood).



Connection with Other Discrepancy Measures

Maximum mean discrepancy (MMD)

• Maximum mean discrepancy (MMD):

$$\mathbb{M}(\boldsymbol{q}, \boldsymbol{p}) = \max_{f \in \mathcal{H}} \{\mathbb{E}_{\boldsymbol{p}} f - \mathbb{E}_{\boldsymbol{q}} f \quad s.t. \quad ||f||_{\mathcal{H}} \leq 1 \}.$$

 \mathcal{H} is the RKHS related to k(x, x').

• KSD can be treated as a MMD using the "Steinalized" kernel $\kappa_p(x, x') = \text{trace}(\mathcal{A}_p^{x}\mathcal{A}_p^{x'}k(x, x'))$, which depends on p (KSD is asymmetric):

$$\mathbb{S}(\boldsymbol{q}, \boldsymbol{p}) = \max_{f \in \mathcal{H}_{\boldsymbol{p}}} \{ \mathbb{E}_{\boldsymbol{p}} f - \mathbb{E}_{\boldsymbol{q}} f \quad s.t. \quad ||f||_{\mathcal{H}_{\boldsymbol{p}}} \le 1 \}$$

 \mathcal{H}_p is the RKHS related to $k_p(x, x')$.

Connection with Other Discrepancy Measures

Fisher divergence

• Fisher divergence: $\mathbb{F}(q, p) = \mathbb{E}_{x \sim q}[||s_p(x) - s_q(x)||_2^2].$

• Used as a learning objective in score matching.

• KSD is a smoothed version of Fisher divergence; we can show

$$\mathbb{S}(\boldsymbol{q}, \boldsymbol{p}) = \mathbb{E}_{\boldsymbol{x} \sim \boldsymbol{q}}[(\boldsymbol{s}_{\boldsymbol{p}}(\boldsymbol{x}) - \boldsymbol{s}_{\boldsymbol{q}}(\boldsymbol{x}))^{\top} \boldsymbol{k}(\boldsymbol{x}, \boldsymbol{x}')(\boldsymbol{s}_{\boldsymbol{p}}(\boldsymbol{x}') - \boldsymbol{s}_{\boldsymbol{q}}(\boldsymbol{x}'))].$$

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KL Divergence

- Fisher divergence = derivative of KL when variables are perturbed by i.i.d. Gaussian.
- KSD = derivative of KL when variables are perturbed by smooth functions in RKHS (see Liu & Wang NIPS 2016, where a variational inference method based on it).

Related Work

- Chwialkowski et al. [2016]: Independent work on quite the same idea (this ICML, the talk before us).
- Oates et al. [2014, 2016, 2017]: Combined Stein's identity with RKHS; used for deriving a super-efficient variance reduction method.
- Gorham and Mackey [2015]: Derived a different (non-kernel) computable Stein discrepancy by enforcing smoothness constraints on a finite number of points, solved by linear programming.

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- Directions:
 - More understandings and applications

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Thank You

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